

Notice of References Cited	Application/Control No. 10/567,776		Applicant(s)/Patent Under Reexamination IWATSU ET AL.	
	Examiner JERMAINE MINCEY		Art Unit 2165	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,408,652 A	04-1995	Hayashi et al.	707/1
*	B	US-5,956,704 A	09-1999	Gautam et al.	707/1
*	C	US-6,298,401 B1	10-2001	Anderson, David B.	710/74
*	D	US-2003/0093400 A1	05-2003	Santosuosso, John Matthew	707/1
*	E	US-2003/0105732 A1	06-2003	Kagalwala et al.	707/1
*	F	US-2003/0154178 A1	08-2003	McIntyre et al.	707/1
*	G	US-2003/0154188 A1	08-2003	Toshimitsu et al.	707/1
*	H	US-2003/0154187 A1	08-2003	Hayakawa et al.	707/1
*	I	US-2005/0160060 A1	07-2005	Swartz et al.	707/001
*	J	US-2005/0149482 A1	07-2005	Dillon, Patrick	707/001
*	K	US-2005/0222968 A1	10-2005	Wayman, Taylor B.	707/001
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.